Fault Attacks on Block Ciphers (Attacks and Automated Evaluation)

Chester Rebeiro IIT Madras

Modern ciphers designed with very strong assumptions

• Kerckhoff's Principle

- The system is completely known to the attacker. This includes encryption & decryption algorithms, plaintext
- only the key is secret
- Why do we make this assumption?
 - Algorithms can be leaked (secrets never remain secret)
 - or reverse engineered



Mallory's task is therefore very difficult

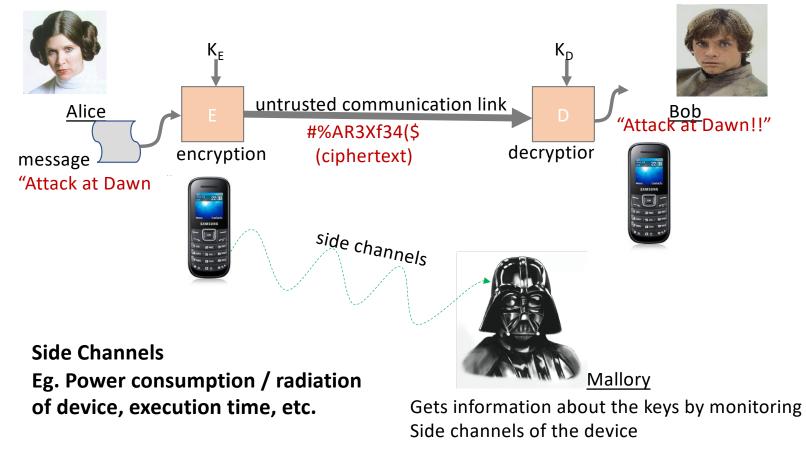
Security as strong as its weakest link

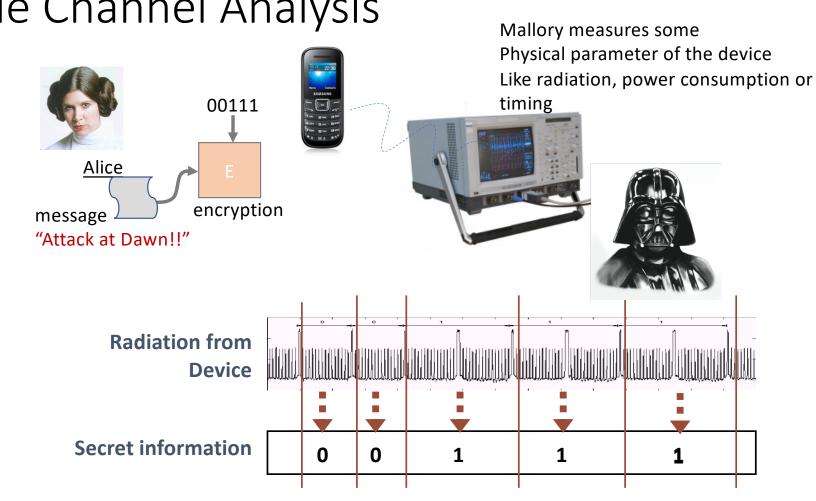
 Mallory just needs to find the weakest link in the systemthere is still hope!!! K_D Κ_E untrusted communication link Bob Alice D #%AR3Xf34^\$ "Attack at Dawn!!" decryption encryption (ciphertext) message "Attack at Dawn!!"

Side Channels



Side Channel Analysis (the weak links)



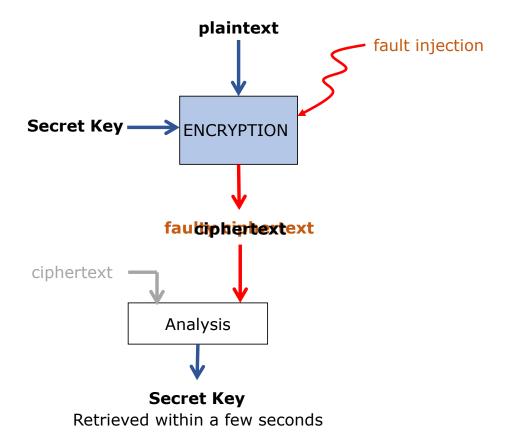


Side Channel Analysis

Types of Side Channel Attacks

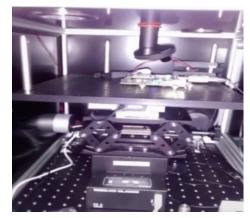
	Passive Attacks	Active Attack
Non-Invasive Attacks	Side-channel attacks: timing attack, Power+EM attacks, cache trace	Insert fault in device without depackaging: using clock glitch, power glitch, change in temperature
Semi—invasive attacks (device is depackaged but no direct electrical contact is made to the chip surface)	Read out memory of device without probing or using the normal read out circuits	Induce faults in depackaged devices with x-rays, EM fields, or optical mechanisms
Invasive Attacks (no limits on what is done with the device)	Probing depackaged device and observe data signals	Depackaged devices are manipulated by probing using laser beams, and focused ion beams.

Fault Attacks on Ciphers

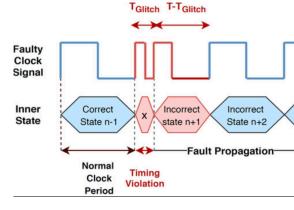


8

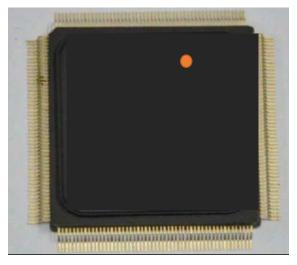
Fault injection needs to be precise



Laser fault injection



Clock glitch fault injection



Attributes of a fault:

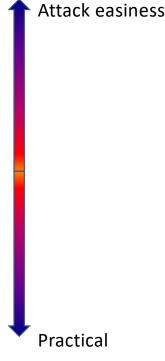
- -- X, Y coordinates for fault injection
- -- time instant laser to be turned on
- -- laser intensity
- -- type of fault (random / stuck at)

Exploitable Fault depend considerably on the cipher algorithm

SEAL Lab, IIT Kharagpur

Fault Models

- Bit model : When fault is injected, exactly one bit in the state is altered eg. 8823124345 → 8833124345
- Byte model : exactly one byte in the state is altered eg. 8823124345 → 8836124345
- Multiple byte model : faults affect more than one byte
 eg. 8823124345 → 8836124333

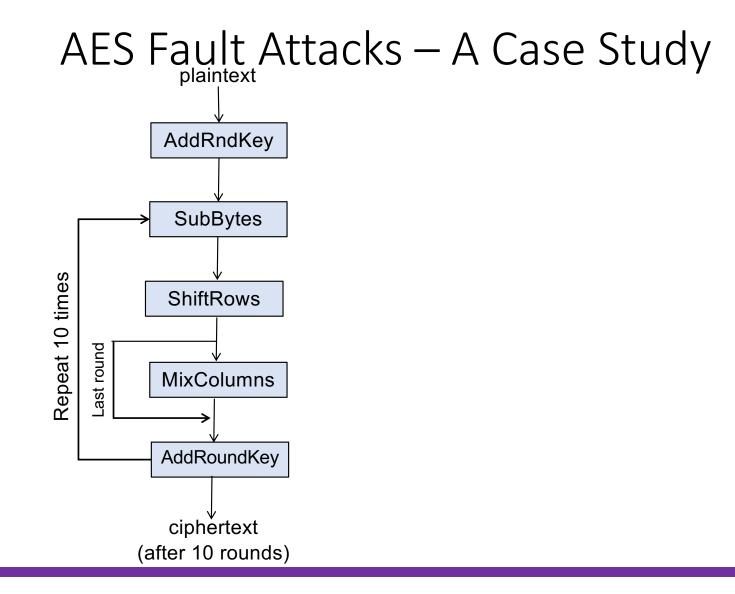


Fault Models

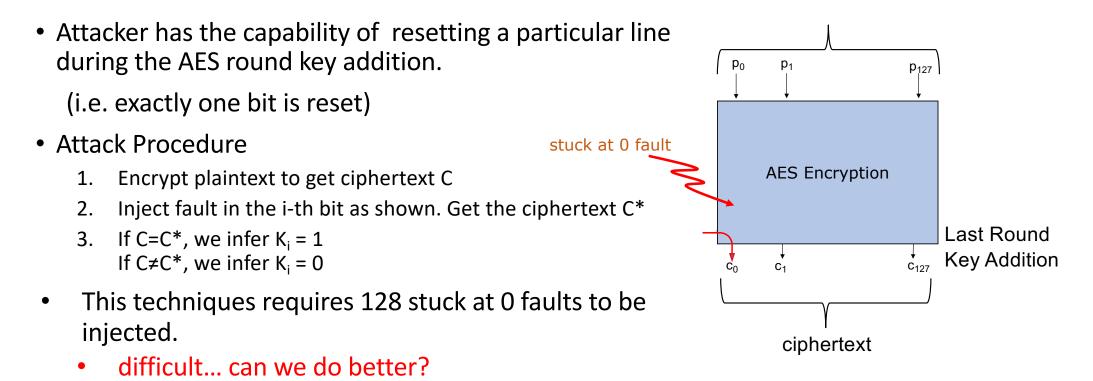
- Stuck at Fault : When fault is injected, bits forced to be stuck at 0 (or 1)
 Attack easiness
 eg. 882312434F → 8823124340
- Transient random model : data is randomly altered for a short duration eg. 8823124345 → 8836124345

Fault injection is difficult.... The attacker would want to reduce the number of faults to be injected

Practical



A Simple Fault Attack on AES



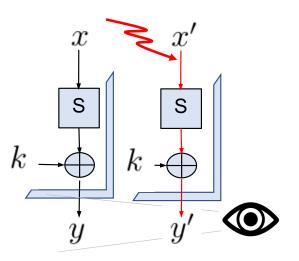
Differential Properties of a cipher

Fault attackers look to solve equations of the form:

 $S^{-1}(y \oplus k) \oplus S^{-1}(y' \oplus k) = \delta$

where y and y' are known

If δ is known, number of solutions for k is very small but, we do not know δ , so try every possible value of δ . $\delta = x \oplus x'$



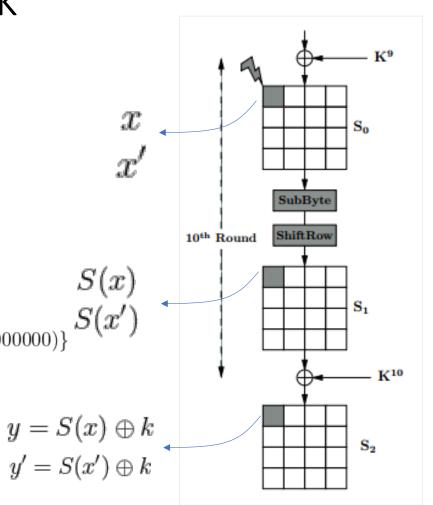
Improving the AES attack last round, bit fault

$$S^{-1}(y \oplus k) \oplus S^{-1}(y' \oplus k) = \delta$$

Suppose δ is a bit fault

 $\delta = \{(0000001), (0000010), (00000100), (0001000), \cdots, (10000000)\}$

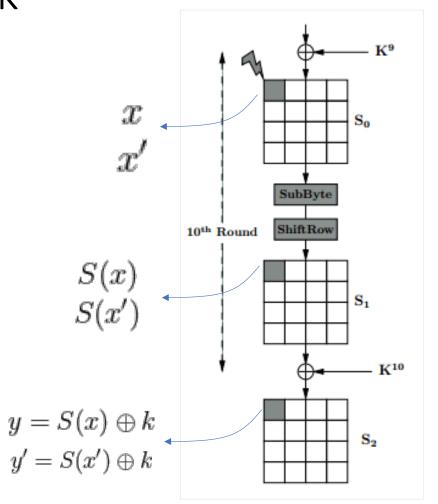
Each value of $\delta\,$ will give one solution for k. Thus, 8 solutions for k



Improving the AES attack last round, bit fault

16 keys, prese δ Thus total complexity of the attack is 8¹⁶ (approximately 2⁴⁸).

16 bit faults required.



Improving the AES attack 9-th round, random fault

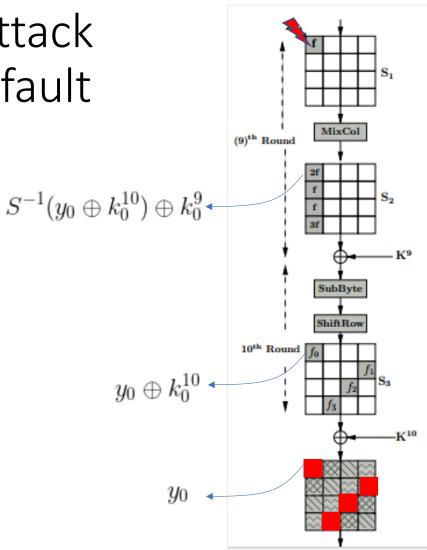
$$S^{-1}(y_0 \oplus k_0^{10}) \oplus S^{-1}(y_0' \oplus k_0^{10}) = 2\delta$$

$$S^{-1}(y_7 \oplus k_7^{10}) \oplus S^{-1}(y_7' \oplus k_7^{10}) = \delta$$

$$S^{-1}(y_{10} \oplus k_{10}^{10}) \oplus S^{-1}(y_{10}' \oplus k_{10}^{10}) = \delta$$

$$S^{-1}(y_{13} \oplus k_{10}^{13}) \oplus S^{-1}(y_{13}' \oplus k_{10}^{13}) = 3\delta$$

Complexity to δ ve the 4 equations is 2⁸. Will deliver 4 key bytes (32 bits).



Improving the AES attack 9-th round, random fault

$$S^{-1}(y_0 \oplus k_0^{10}) \oplus S^{-1}(y_0' \oplus k_0^{10}) = 2\delta$$

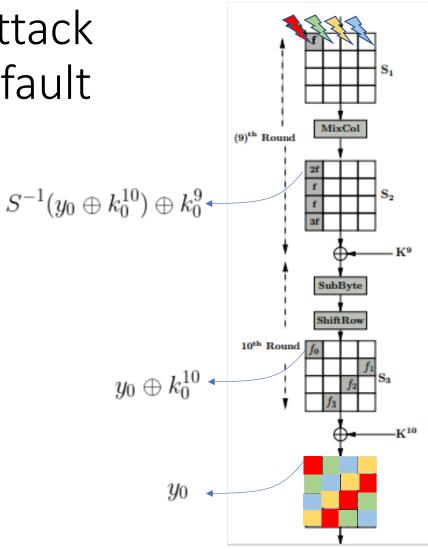
$$S^{-1}(y_7 \oplus k_7^{10}) \oplus S^{-1}(y_7' \oplus k_7^{10}) = \delta$$

$$S^{-1}(y_{10} \oplus k_{10}^{10}) \oplus S^{-1}(y_{10}' \oplus k_{10}^{10}) = \delta$$

$$S^{-1}(y_{13} \oplus k_{10}^{13}) \oplus S^{-1}(y_{13}' \oplus k_{10}^{13}) = 3\delta$$

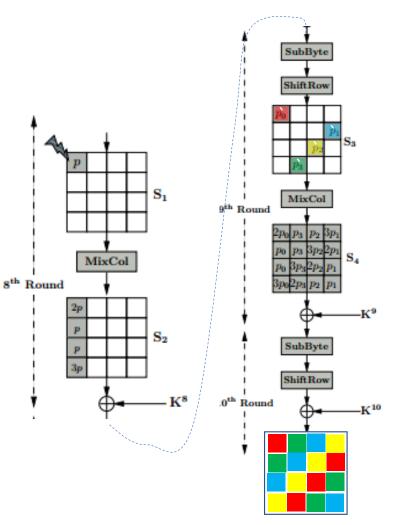
Complexity to δ ve the 4 equations is 2⁸. Will deliver 4 key bytes (32 bits).

4 faults required to get 128 bits of key. Total complexity, $2^{8^{*4}}=2^{32}$

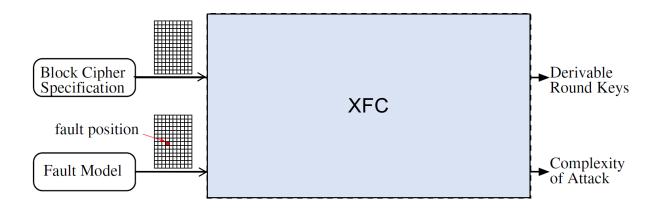


Improving the AES attack 8th round, random fault

- A single fault injected in the 8th round will spread to 4 bytes in the 9th round.
- This is equivalent to having 4 faults in each of the 4 columns.
- A single fault can thus be used to determine all key bytes.
- The offline key space is 2³² as before. This can be reduced to 2⁸ using the key expansion algorithm



XFC: A Framework for Exploitable Fault Characterization in Block Ciphers



Cipher	\mathcal{F}_i	Round Number	#Derived Keys	Offline Complexity
AES	1-27 28-31	1-7 7-8	0 128	N/A 2 ⁸ 2 ⁸
	32-35 36-40	8-9 9-10	$\begin{array}{c} 32 \\ 0 \end{array}$	N/A

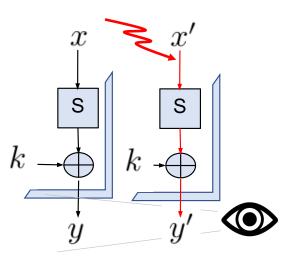
The Central Idea

Fault attackers look to solve equations of the form:

 $S^{-1}(y \oplus k) \oplus S^{-1}(y' \oplus k) = \delta$

where y and y' are known, k and δ are unknown.

 $\delta = x \oplus x'$



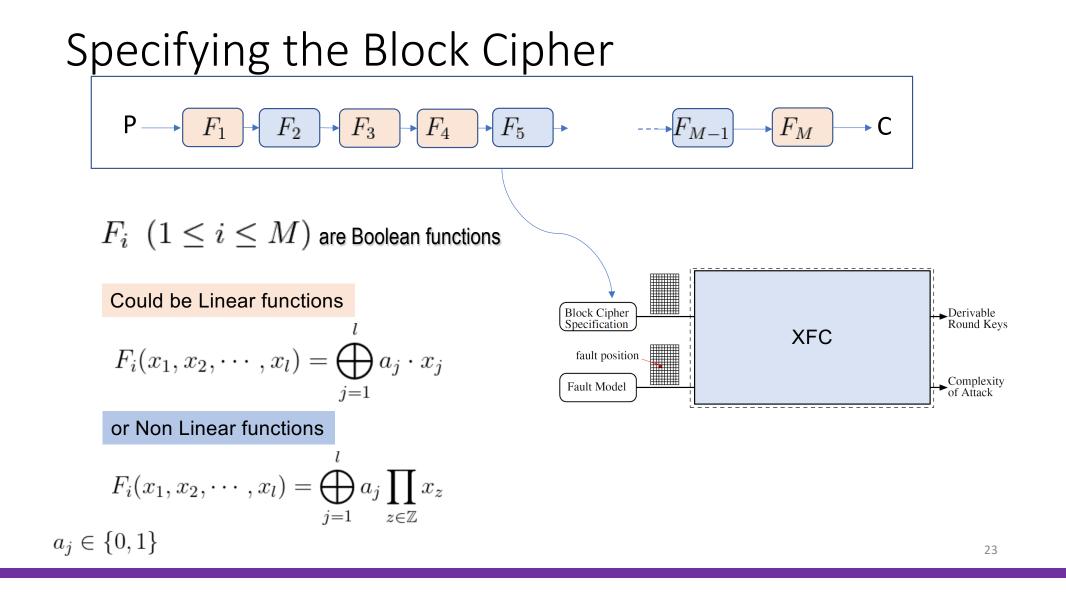
The Central Idea

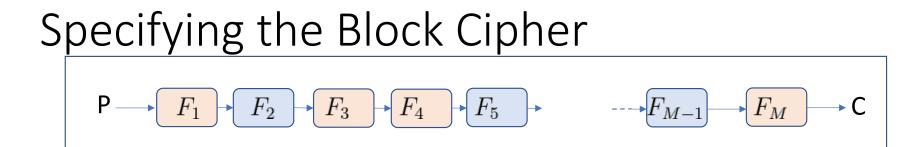
If multiple equations of this form are found, then the complexity is reduced considerably

$$\begin{split} \mathbf{S}^{-1}(y_1 \oplus k_1) \oplus S^{-1}(y_1' \oplus k_1) &= g_1(\delta) \\ \mathbf{S}^{-1}(y_2 \oplus k_2) \oplus S^{-1}(y_2' \oplus k_2) &= g_2(\delta) \\ \mathbf{S}^{-1}(y_3 \oplus k_3) \oplus S^{-1}(y_3' \oplus k_3) &= g_3(\delta) \\ &\vdots &\vdots &\vdots \\ \mathbf{S}^{-1}(y_N \oplus k_N) \oplus S^{-1}(y_N' \oplus k_N) &= g_N(\delta) \end{split}$$
 Linear function δ

Only key tuples (k_1, k_2, \dots, k_N) that satisfy all N equations are potential candidates.

Assuming δ is a byte, we can recover N bytes of key with a complexity of 2^8





 $F_i \ \ (1 \leq i \leq M)$ are Boolean functions

Could be Linear functions

$$F_i(x_1, x_2, \cdots, x_l) = \bigoplus_{j=1}^l a_j \cdot x_j$$

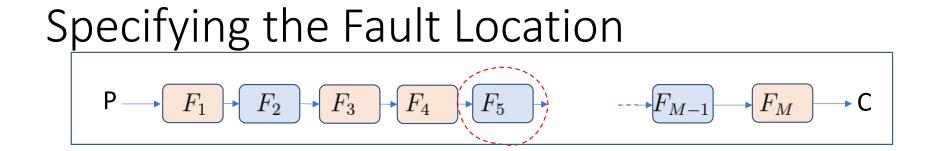
or Non Linear functions

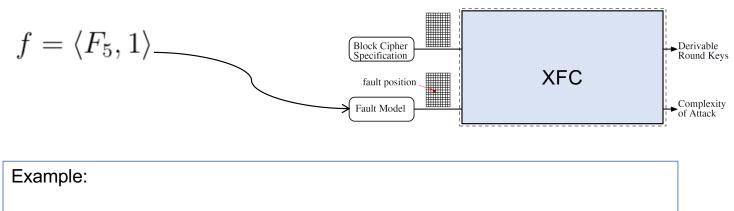
$$F_i(x_1, x_2, \cdots, x_l) = \bigoplus_{j=1}^l a_j \prod_{z \in \mathbb{Z}} x_z$$

1

 $a_j \in \{0,1\}$

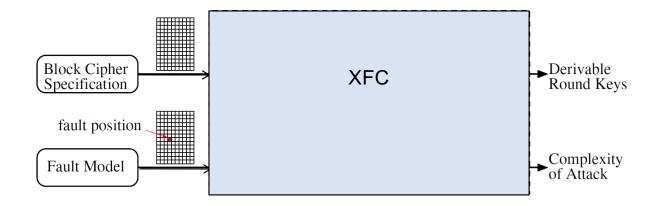
AES Specification
40 functions F_1 (AddRoundKey) is Linear F_2 (SubBytes of Round 1) is Non-Linear F_3 (ShiftRows of Round 1) is Linear F_4 (MixColumns of Round 1) is Linear
F_5 (AddRoundKey) is Linear F_6 (SubBytes of Round 2) is Non-Linear F_7 (ShiftRows of Round 2) is Linear F_8 (MixColumns of Round 2) is Linear
F_{37} (AddRoundKey of Round 9) is Linear F_{38} (SubBytes of Round 10) is Non-Linear F_{39} (ShiftRows of Round 10) is Linear F_{40} (AddRoundKey of Round 10) is Linear





A Fault in the 1st Byte of the 5th Round SubBytes operation

XFC's Two Phases



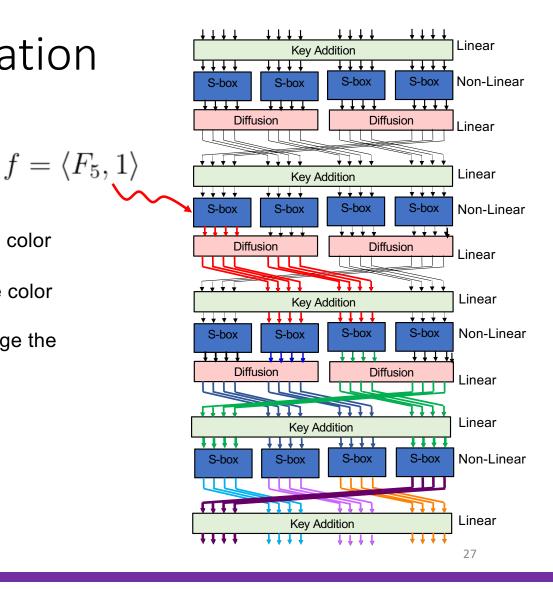
(Phase 1) Fault Propagation

Color the fault affected part.

Propagate and color as follows.

- 1. When passing through a linear layer, retain same color
- 2. When passing through a non-linear layer, change color
- 3. If two bytes of different colors are combined, change the color.

Same colors are linearly correlated Different colors are not correlated



(Phase 2) Key Determination

Back propagate and try to match colors whenever we hit an s-box

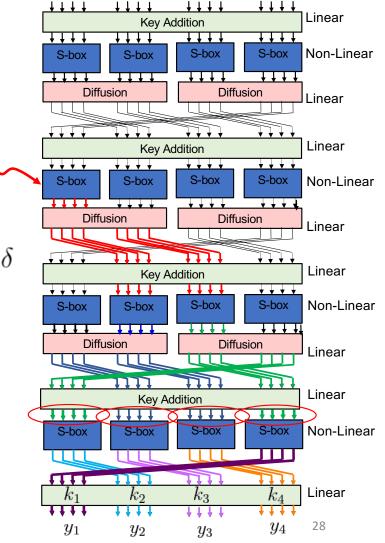
 $f = \langle F_5, 1 \rangle$

 $S^{-1}(y_1 \oplus k_1) \oplus S^{-1}(y_1' \oplus k_1) = g_1(\delta)$ $S^{-1}(y_2 \oplus k_2) \oplus S^{-1}(y_2' \oplus k_2) = g_2(\delta)$

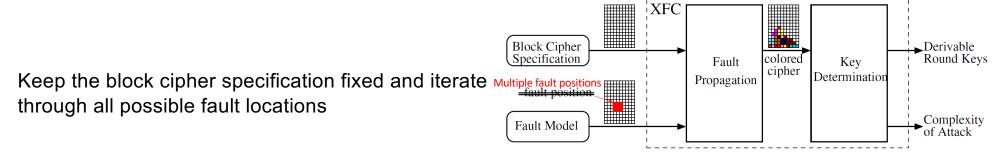
The offline complexity to find (k_1,k_2) is 2⁴ ; ie the possible values δ can take.

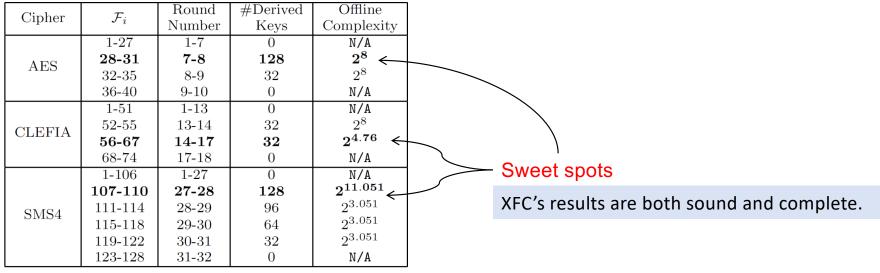
Similarly,

 $S^{-1}(y_3 \oplus k_3) \oplus S^{-1}(y'_3 \oplus k_3) = g_3(\delta)$ $S^{-1}(y_4 \oplus k_4) \oplus S^{-1}(y'_4 \oplus k_4) = g_4(\delta)$ Can be used to determine (k_3, k_4)



Finding the Sweet Spot

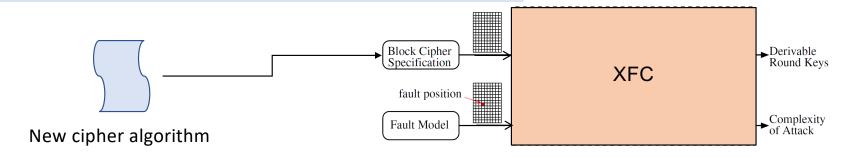




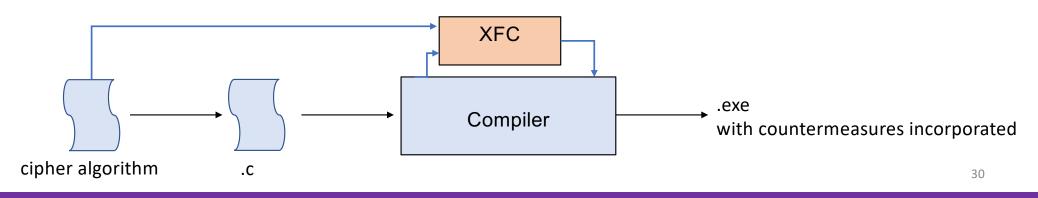
@ACM TODAES 2020

Applications of XFC

Automatically evaluate new cipher algorithms for Fault Attacks

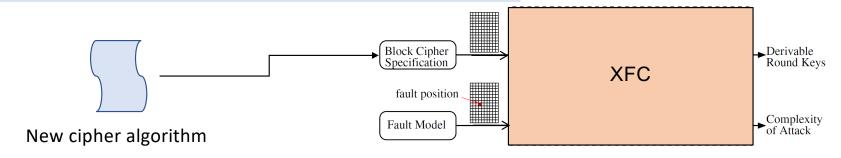


Fault Attack aware Compilers (for software)

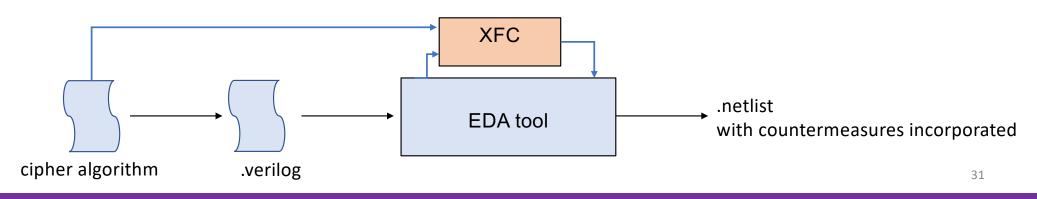


Applications of XFC

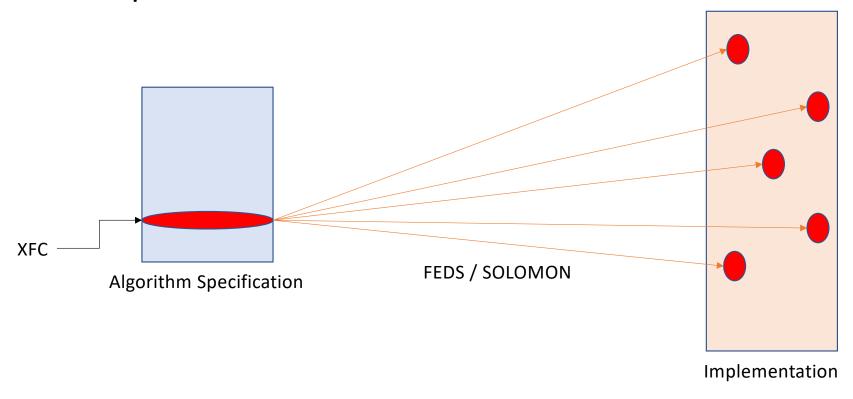
Automatically evaluate new cipher algorithms for Fault Attacks

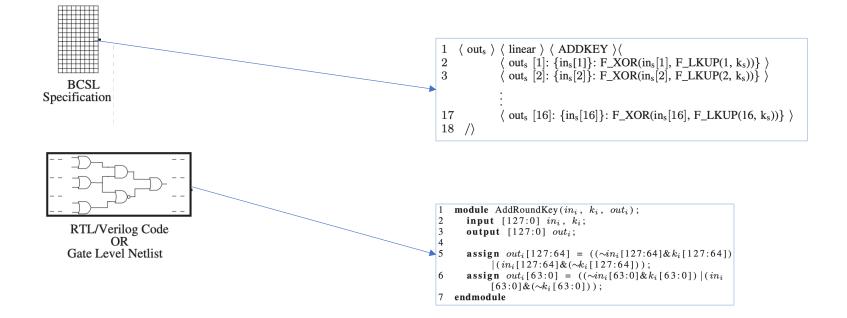


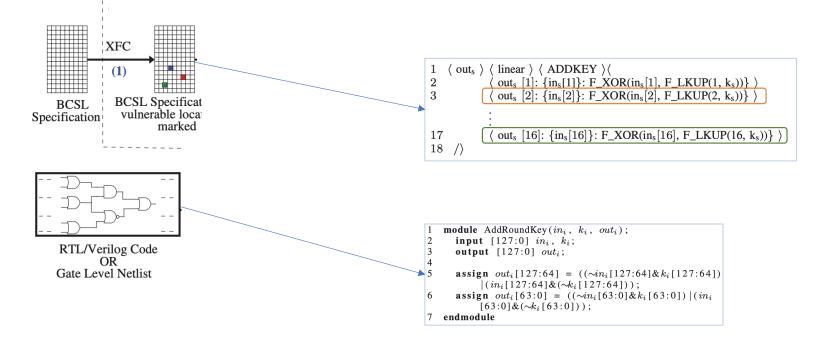
Fault Attack aware EDA tools (for VLSI design)

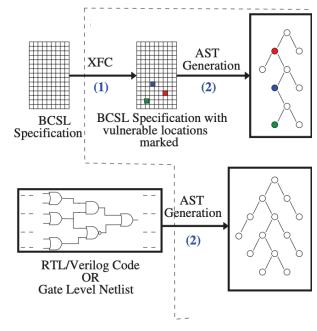


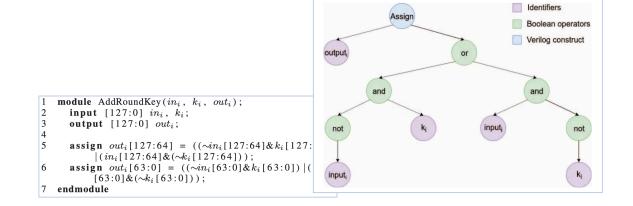
Mapping fault vulnerable operations to an implementation

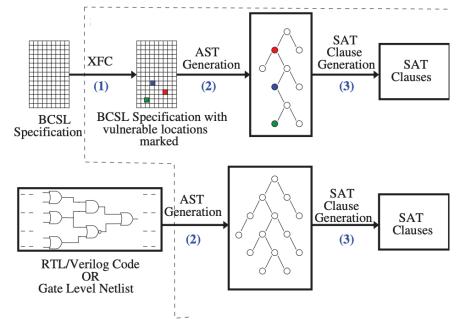




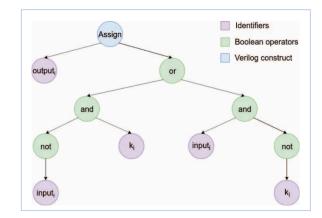






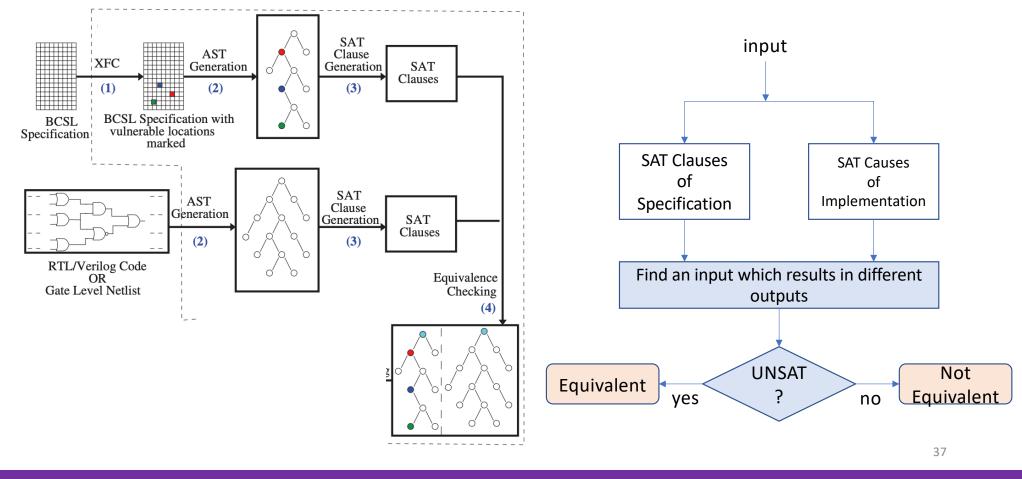


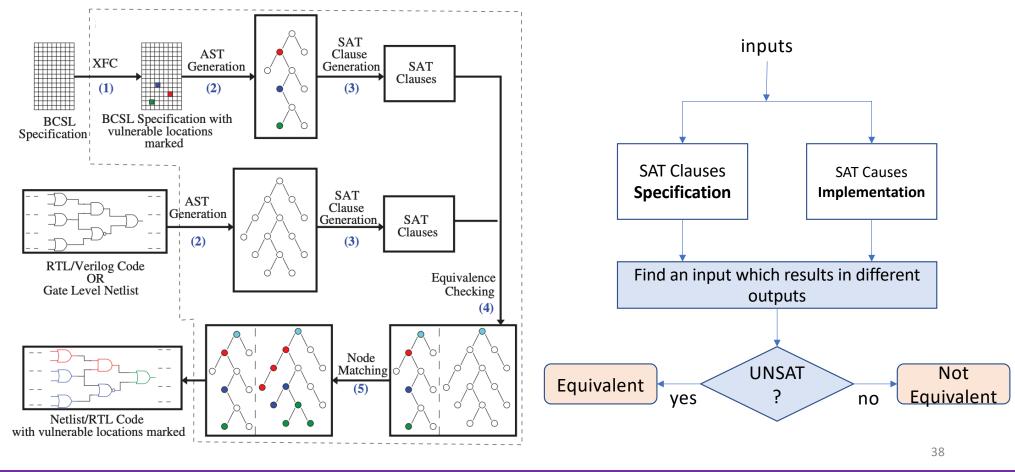
1	module AddRoundKey (in_i, k_i, out_i) ;
T	
2	input [127:0] in_i , k_i ;
3	output $[127:0]$ out _i ;
4	
5	assign $out_i[127:64] = ((\sim in_i[127:64]\&k_i[127:64]))$
	$(in_i[127:64]\&(\sim k_i[127:64]));$
6	assign $out_i[63:0] = ((\sim in_i[63:0] \& k_i[63:0]) (in_i)$
	$[63:0]\&(\sim k_i [63:0]));$
7	endmodule



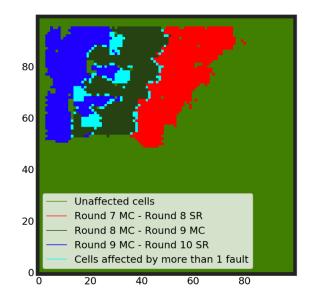
 $((\neg in_i[127:64]\&k_i[127:64]) | (\neg k_i[127:64]\&in_i[127:64])) || 0^{64},$ and $((\neg in_i[127:64]\&k_i[127:64]) | (\neg k_i[127:64]\&in_i[127:64]))$

 $|| ((\neg in_i [63:0] \& k_i [63:0]) | (\neg k_i [63:0] \& in_i [63:0])),$

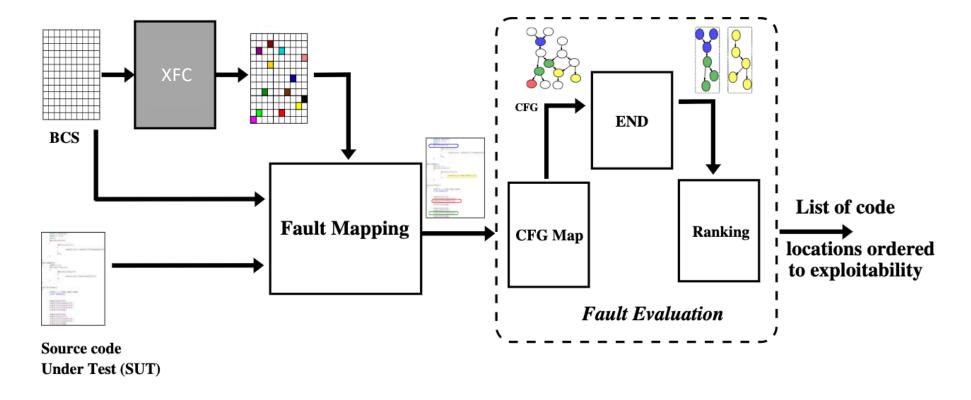




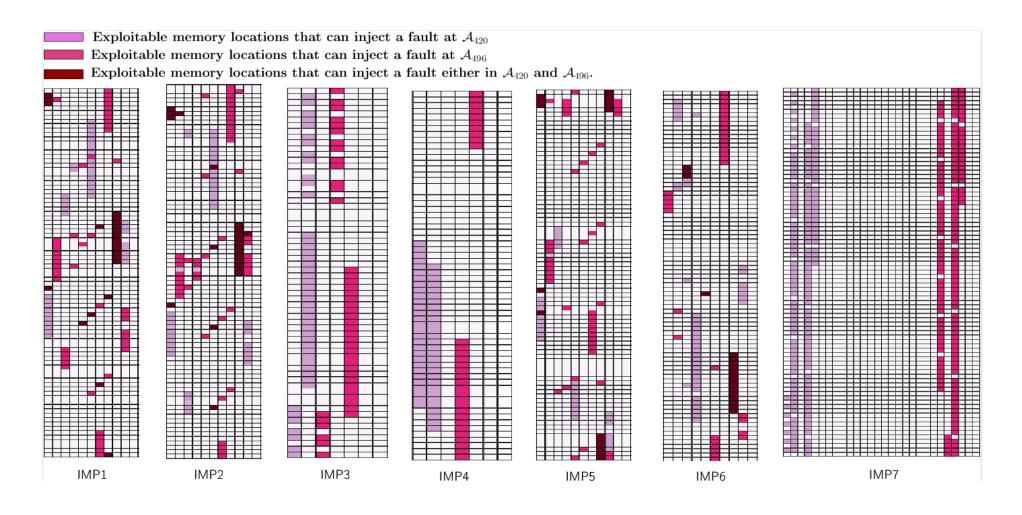
		AES _C	AESL	CLEFIA	Simon
No. of	spec	50379		28286	3961
AST nodes	imple	2046	46041	3832	141
	(1)	0.02	0.02	0.02	0.06
	(2) spec	1.92		1.08	0.17
Execution	(2) <i>imple</i>	0.12	1.75	0.17	0.03
time of	(3) <i>spec</i>	5.72		3.31	0.44
each step	(3) <i>imple</i>	0.23	5.54	0.56	0.36
(in sec)	(4)	437.06	2.64	46.40	0.02
	(5)	13.8	0.92	136.7	0.24
	Total	458.87	18.51	188.24	1.32
Fault	Fault	7 MixColumns to		13 DXor to	30 Rot_2 to
Vulner-	location	8 ShiftRows		14 SubByte	30 Concat
-ability analysis	Verilog lines	365	4173	609	24
	Gates	4590	10477	5324	52
		(11.56%)	(9.85%)	(5.53%)	(2.83%)



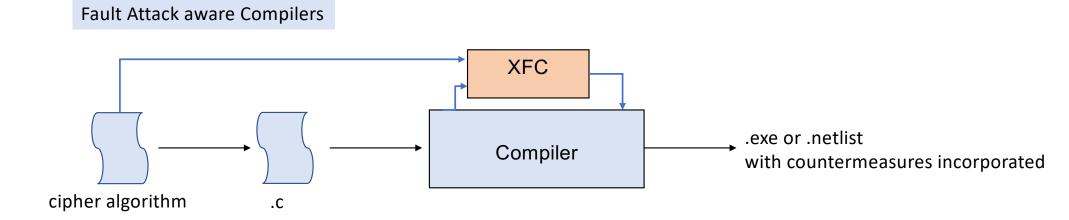
FEDS: An Automated framework for detect fault attack vulnerabilities in **Software**

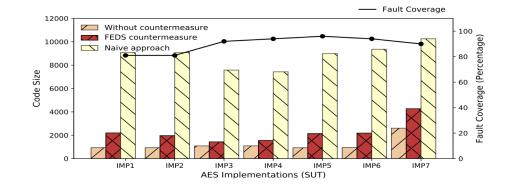


Fault Evaluation of 7 different implementations of AES



Automated Countermeasures using XFC





42

Thank you for your attention

Source code: https://bitbucket.org/casl/faultanalysis/src/master/